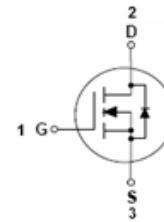




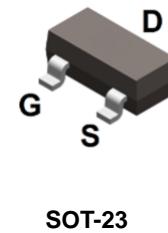
## Features

- Advanced trench cell design
- Extremely low threshold voltage



## Typical Applications

- N-channel enhancement mode effect transistor



## Mechanical Data

- Case: SOT-23
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte Tin-Plated Leads, Solderability-per MIL-STD-202, Method 208

SOT-23

## Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
2N7002V	SOT-23	3000 pcs / Tape & Reel	7002V

## Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	60	V
Gate-to-Source Voltage	$V_{GSS}$	$\pm 30$	V
Continuous Drain Current ( $T_C = 25^\circ\text{C}$ ) <sup>*1</sup>	$I_D$	300	mA
Continuous Drain Current ( $T_A = 25^\circ\text{C}$ ) <sup>*1</sup>	$I_D$	250	mA
Continuous Drain Current ( $T_A = 70^\circ\text{C}$ ) <sup>*1</sup>		200	mA
Pulsed Drain Current ( $t_p = 10\mu\text{s}$ , $T_A = 25^\circ\text{C}$ )	$I_{DM}$	2000	mA
Single Pulse Avalanche Energy <sup>*3</sup>	$E_{AS}$	0.11	mJ
Power Dissipation <sup>*1</sup>	$P_D$	0.35	W
Operating Junction Temperature Range	$T_J$	-55 to +150	°C
Storage Temperature Range	$T_{STG}$	-55 to +150	°C

## Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case <sup>*1</sup>	$R_{\theta JC}$	-	217	230	°C/W
Thermal Resistance Junction-to-Air <sup>*1</sup>	$R_{\theta JA}$	-	319	357	°C/W


**Electrical Characteristics** (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

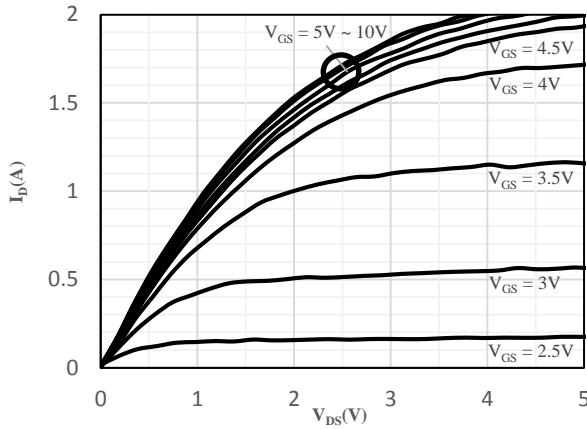
Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
$V_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}$ , $I_D = 250\mu\text{A}$	60	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 60\text{V}$ , $V_{GS} = 0\text{V}$	-	-	1	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30\text{V}$ , $V_{DS} = 0\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$R_{DS(ON)}$	Drain-Source On-resistance <sup>*2</sup>	$V_{GS} = 10\text{V}$ , $I_D = 0.5\text{A}$	-	0.9	3	$\Omega$
		$V_{GS} = 4.5\text{V}$ , $I_D = 0.075\text{A}$	-	1	3.5	
$V_{GS(TH)}$	Static Drain-Source On-resistance	$V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$	1	1.5	2.5	V
$R_G$	Gate Resistance	$V_{GS} = 0\text{V}$ , $f = 1\text{MHz}$	-	51	-	$\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1.0\text{MHz}$	-	35	-	pF
$C_{oss}$	Output Capacitance		-	7	-	
$C_{rss}$	Reverse Transfer Capacitance		-	3	-	
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-on Delay Time <sup>*4</sup>	$V_{DD} = 30\text{V}$ $V_{GS} = 10\text{V}$ $R_G = 25\Omega$ $I_D = 0.2\text{A}$	-	3.6	-	ns
$t_r$	Turn-on Rise Time <sup>*4</sup>		-	3.3	-	
$t_{d(off)}$	Turn-Off Delay Time <sup>*4</sup>		-	20	-	
$t_f$	Turn-Off Fall Time <sup>*4</sup>		-	11	-	
$Q_G$	Total Gate-Charge	$V_{DD} = 10\text{V}$ $V_{GS} = 4.5\text{V}$ $I_D = 0.2\text{A}$	-	0.41	-	nC
$Q_{GS}$	Gate to Source Charge		-	0.15	-	
$Q_{GD}$	Gate to Drain (Miller) Charge		-	0.2	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage <sup>*2</sup>	$I_S = 0.3\text{A}$ , $V_{GS} = 0\text{V}$	-	1.09	1.5	V

Notes:

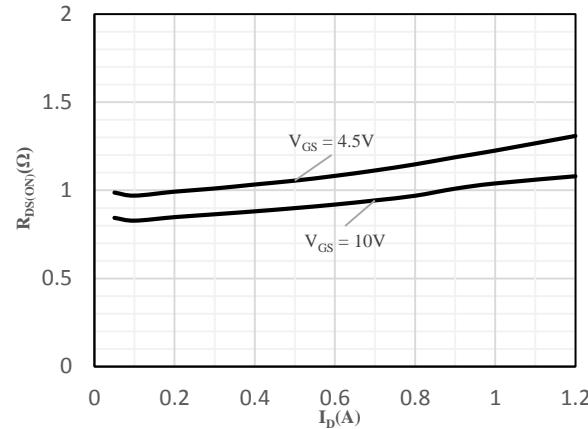
1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper
2. The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$
3. The  $E_{AS}$  data shows Max. rating. The test condition is  $V_{DD} = 30\text{V}$ ,  $V_{GS} = 15\text{V}$ ,  $L = 0.1\text{mH}$
4. Guaranteed by design, not subject to production



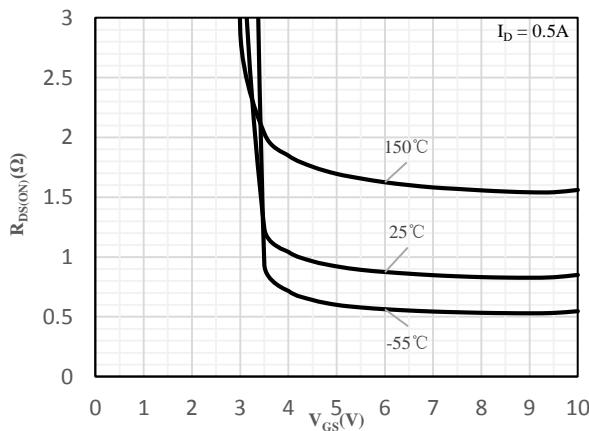
## Ratings and Characteristic Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)



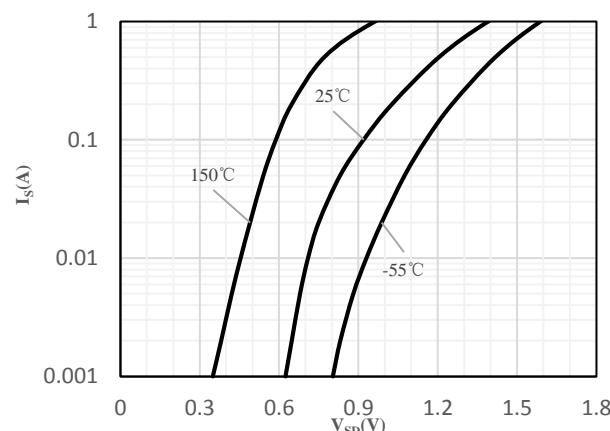
**Fig 1 Typical Output Characteristics**



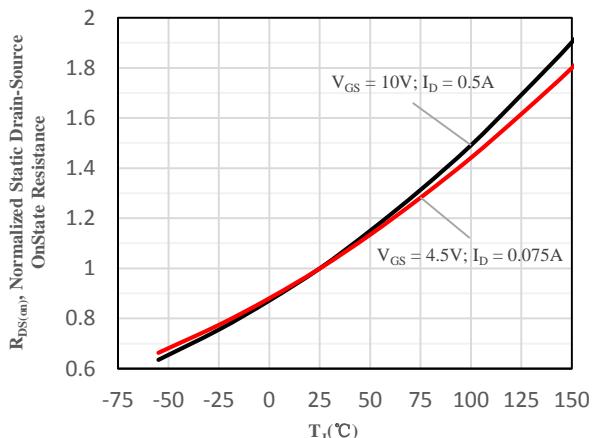
**Fig 2 On-Resistance vs. Drain Current  
and Gate Voltage**



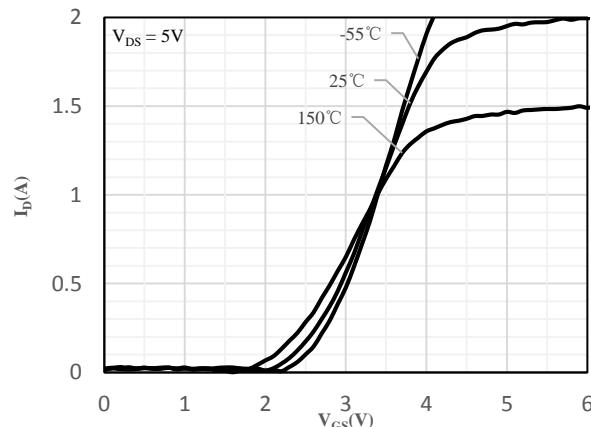
**Fig 3 On-Resistance vs. Gate-Source Voltage**



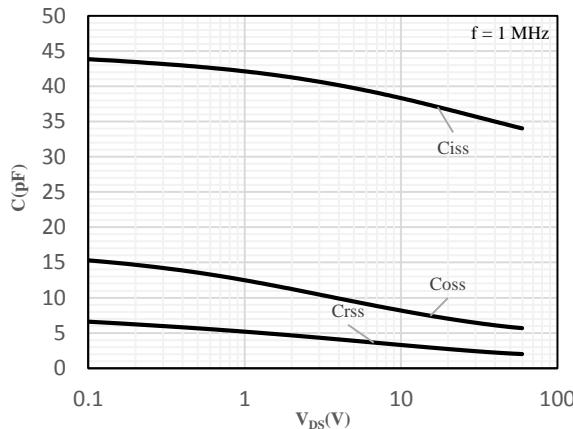
**Fig 4 Body-Diode Characteristics**



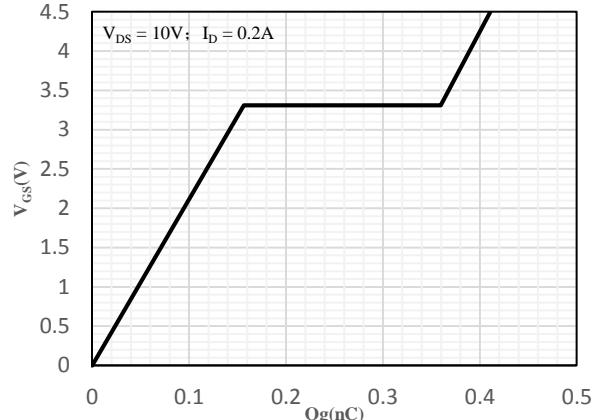
**Fig 5 Normalized On-Resistance vs. Junction  
Temperature**



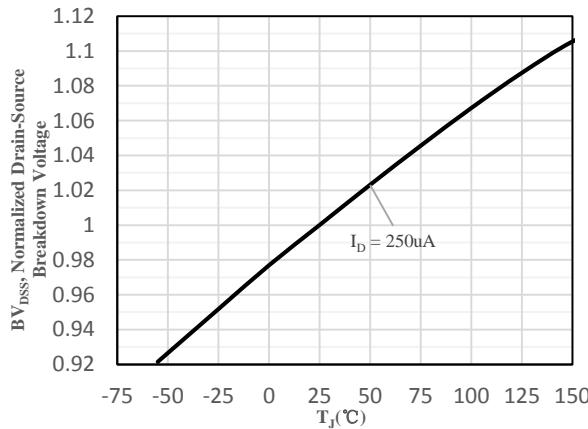
**Fig 6 Transfer Characteristics**



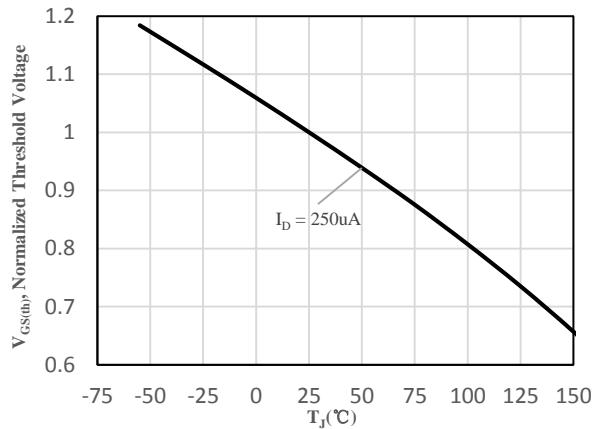
**Fig 7 Capacitance Characteristics**



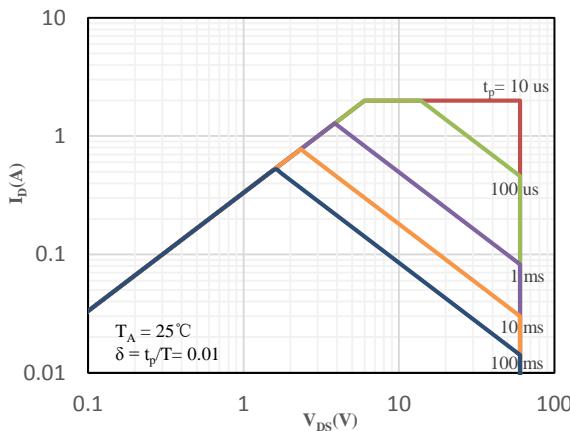
**Fig 8 Gate-Charge Characteristics**



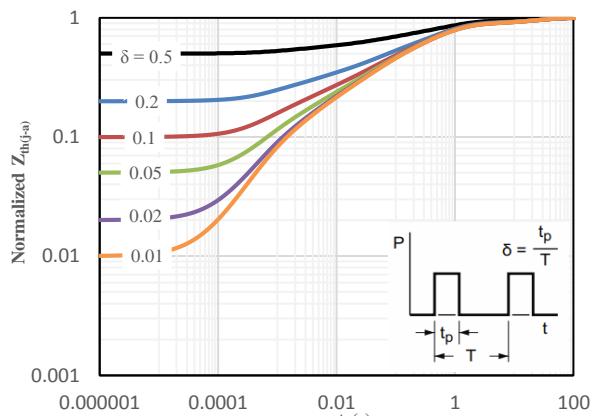
**Fig 9 Normalized Breakdown Voltage  
vs. Junction Temperature**



**Fig 10 Normalized  $V_{GS(\text{th})}$  vs. Junction Temperature**



**Fig 11 Safe Operation Area**

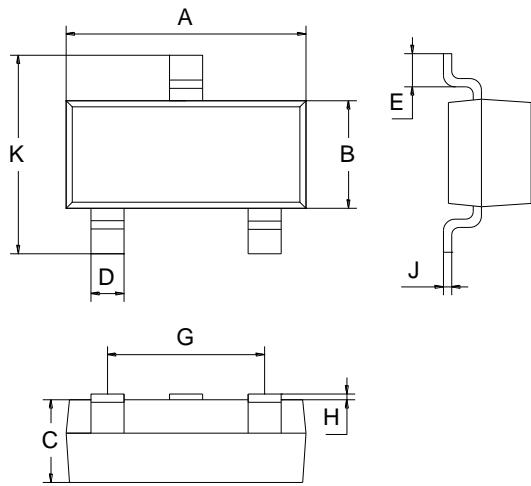


**Fig 12 Normalized Maximum transient thermal  
impedance**



## Package Outline Dimensions (Unit: mm)

**SOT-23**



<b>SOT-23</b>		
Dimension	Min.	Max.
A	2.70	3.10
B	1.10	1.50
C	0.90	1.10
D	0.30	0.50
E	0.35	0.48
G	1.80	2.00
H	0.02	0.10
J	0.05	0.15
K	2.20	2.60

## Mounting Pad Layout (Unit: mm)

**SOT-23**

